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 Inputs Are TTL-Voltage Compatible Speed of Bipolar F, AS, and S, With Significantly Reduced Power Consumption 	CD54ACT00 F PACKAGE CD74ACT00 E OR M PACKAGE (TOP VIEW)
 Balanced Propagation Delays 	1A 🛛 1 💛 14 🗍 V _{CC}
 ±24-mA Output Drive Current – Fanout to 15 F Devices 	1B [2 13] 4B 1Y [3 12] 4A
 SCR-Latchup-Resistant CMOS Process and Circuit Design 	2A [4 11] 4Y 2B [5 10] 3B
 Exceeds 2-kV ESD Protection Per MIL-STD-883, Method 3015 	2Y [6 9] 3A GND [7 8] 3Y

description

The 'ACT00 devices contain four independent 2-input NAND gates. Each gate performs the Boolean function of $Y = \overline{A \cdot B}$ or $Y = \overline{A} + \overline{B}$ in positive logic.

TA	PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING
	PDIP – E	Tube	CD74ACT00E	CD74ACT00E
-40°C to 85°C	SOIC – M	Tube	CD74ACT00M	ACT00M
		Tape and reel	CD74ACT00M96	ACTOON
–55°C to 125°C	CDIP – F	Tube	CD54ACT00F3A	CD54ACT00F3A

ORDERING INFORMATION

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

(each gate)							
INP	UTS	OUTPUT					
Α	В	Y					
н	Н	L					
L	Х	н					
х	L	н					

logic diagram, each gate (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 6 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1)	
Output clamp current, I_{OK} (V _O < 0 or V _O > V _{CC}) (see Note 1)	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 2): E package	80°C/W
M package	
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		T _A =	25°C	CD54A	CT00	CD74ACT00		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage	4.5	5.5	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2		2		2		V
VIL	Low-level input voltage		0.8		0.8		0.8	V
VI	Input voltage	0	VCC	0	VCC	0	VCC	V
Vo	Output voltage	0	VCC	0	VCC	0	VCC	V
ЮН	High-level output current		-24		-24		-24	mA
IOL	Low-level output current		24		24		24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0	10	0	10	0	10	ns/V
ТА	Operating free-air temperature			-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CO	TEST CONDITIONS		T _A = 2	25°C	CD54A	CT00	CD74A	CT00	UNIT
PARAMETER	TEST CO	INDITION5	VCC	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
		I _{OH} = -50 μA	4.5 V	4.4		4.4		4.4		
Vau		I _{OH} = -24 mA	4.5 V	3.94		3.7		3.8		V
Vон	$V_{I} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -50 \text{ mA}^{\ddagger}$	5.5 V			3.85				V
		I _{OH} = -75 mA‡	5.5 V					3.85		
	M M M m	I _{OL} = 50 μA	4.5 V		0.1		0.1		0.1	
Ve		I _{OL} = 24 mA	4.5 V		0.36		0.5		0.44	V
VOL	VI = VIH or VIL	I _{OL} = 50 mA‡	5.5 V				1.65			v
		I _{OL} = 75 mA‡	5.5 V						1.65	
lj	$V_I = V_{CC}$ or GND		5.5 V		±0.1		±1		±1	μA
ICC	$V_I = V_{CC}$ or GND,	I ^O = 0	5.5 V		4		80		40	μA
ΔICC	$V_{I} = V_{CC} - 2.1 V$		4.5 V to 5.5 V		2.4		3		2.8	mA
Ci					10		10		10	pF

[‡] Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.



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ACT INPUT LOAD TABLE

 $\begin{tabular}{|c|c|c|c|} \hline INPUT & UNIT LOAD \\ \hline A \ or \ B & 0.15 \\ \hline Unit \ load \ is \ \Delta I_{CC} \ limit \ specified \\ in \ electrical \ characteristics \\ table \ (e.g., \ 2.4 \ mA \ at \ 25^\circ C). \\ \hline \end{tabular}$

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V, C_L = 50 pF (unless otherwise noted) (see Figure 1)

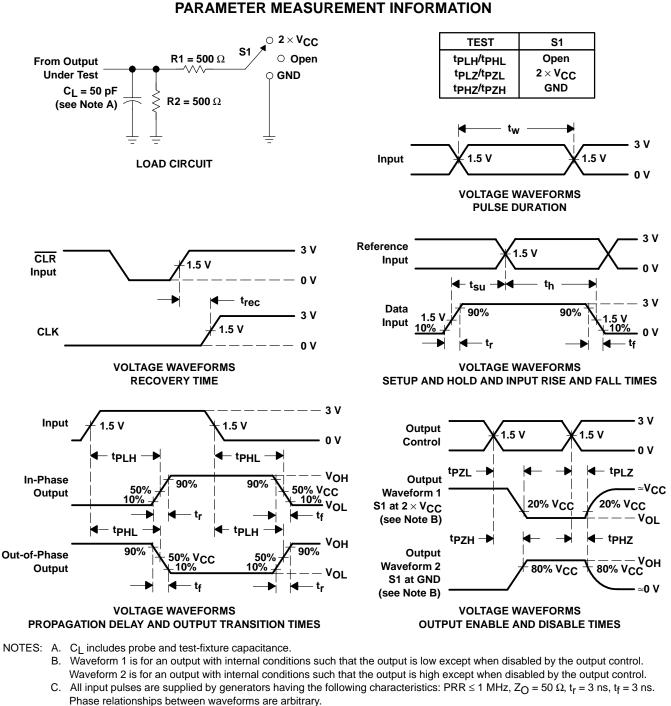
PARAMETER	FROM	FROM TO		CT00	CD74A	СТОО	UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	MAX	MIN	MAX	UNIT
^t PLH	A or B	V	3.2	10.8	3.4	9.5	
^t PHL	AUB	T	4	13.2	2.8	8	ns

operating characteristics, V_{CC} = 5 V, T_A = 25°C

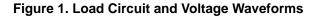
	PARAMETER	TYP	UNIT
Cpd	Power dissipation capacitance	45	pF



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- D. For clock inputs, fmax is measured with the input duty cycle at 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. tpLH and tpHL are the same as tpd.
- G. tpzL and tpzH are the same as ten.
- H. tpLz and tpHz are the same as tdis.





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